TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSIII)

TPCS8212

Lithium Ion Battery Applications

- Small footprint due to small and thin package
- Low drain-source ON resistance: $RDS(ON) = 16 \text{ m}\Omega \text{ (typ.)}$
- High forward transfer admittance: $|Y_{fs}| = 11 \text{ S (typ.)}$
- Low leakage current: $IDSS = 10 \mu A (max) (VDS = 20 V)$
- Enhancement-mode: $V_{th} = 0.5 \sim 1.2 \text{ V (VDS} = 10 \text{ V, ID} = 200 \text{ }\mu\text{A})$
- Common drain

Maximum Ratings (Ta = 25°C)

Char	acteristics	Symbol	Rating	Unit	
Drain-source vol	tage	V_{DSS}	20	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	20	V	
Gate-source voltage		V _{GSS}	±12	V	
Drain current	DC (Note 1)	I _D	6	Α	
Diain current	Pulse (Note 1)	device on (Note 3a) PD (1) 1.1 device value operation PD (2) 0.75	A		
Drain power	Single-device operation (Note 3a)	P _{D (1)}	1.1	W	
dissipation (t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.75		
Drain power dissipation (t = 10 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.6	VV	
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.35		
Single pulse avalanche energy (Note 4)		E _{AS}	46.8	mJ	
Avalanche current		I _{AR}	6	Α	
Repetitive avalanche energy Single-device value at dual operation (Note 2a, 3b, 5)		E _{AR}	0.075	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Unit: mm

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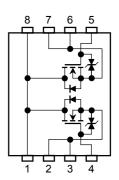
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2-3R1E

Weight: 0.035 g (typ.)

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Circuit Configuration



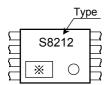
Note: (Note 1), (Note 2), (Note 3), (Note 4), (Note 5) Please see next page.

This transistor is an electrostatic sensitive device. Please handle with caution.

Thermal Characteristics

Characteristics	Symbol	Max	Unit		
The small resistance should be embigued	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	114	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th} (ch-a) (2)	167		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	208		
(t = 10 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	357	°C/W	

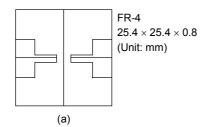
Marking (Note 6)



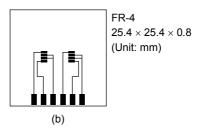
Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

a) Device mounted on a glass-epoxy board (a)



b) Device mounted on a glass-epoxy board (b)



Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.).
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).
- Note 4: $V_{DD}=16~V,~T_{Ch}=25^{\circ}C$ (initial), L = 1.0 mH, R_G = 25 $\Omega,~I_{AR}=6~A$
- Note 5: Repetitive rating; pulse width limited by max channel temperature.
- Note 6: o on lower right of the marking indicates Pin 1.

 * shows lot number. (year of manufacture: last decimal digit of the year of manufacture, month of manufacture: January to December are denoted by letters A to L respectively)

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Electrical Characteristics (Ta = 25°C)

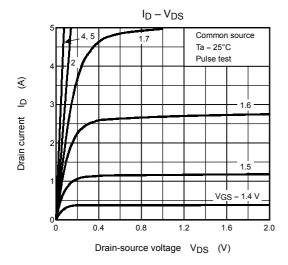
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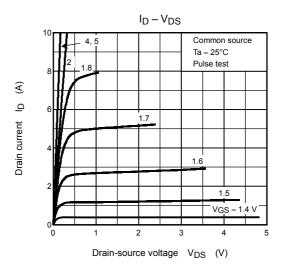
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Drain cut-OFF current		I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V	_	_	10	μА
Drain-source breakdown voltage		V _{(BR)DSS}	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	20			V
		V _{(BR)DSX}	$I_D = 10 \text{ mA}, V_{GS} = -12 \text{ V}$	8			
Gate threshold v	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_D = 200 \mu\text{A}$	0.5		1.2	>
			$V_{GS} = 2.0 \text{ V}, I_D = 4.2 \text{ A}$	_	26	45	mΩ
Drain-source ON resistance		R _{DS} (ON)	$V_{GS} = 2.5 \text{ V}, I_D = 4.2 \text{ A}$	_	21	29	
			$V_{GS} = 4.0 \text{ V}, I_D = 4.8 \text{ A}$	_	16	24	
Forward transfer admittance		Y _{fs}	$V_{DS} = 10 \text{ V}, I_D = 3.0 \text{ A}$	5.5	11	_	S
Input capacitance		C _{iss}		_	1590	_	
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	180	_	pF
Output capacitance		Coss		_	200	_	
Switching time	Rise time	t _r	ACS 0 N	_	6.4	_	
	Turn-ON time	t _{on}			22		ns
	Fall time	t _f			10		i lib
	Turn-OFF time	t _{off}	$V_{DD} \simeq 10 \text{ V}$ Duty $\leq 1\%$, $t_W = 10 \mu\text{s}$		42		
Total gate charge (gate-source plus gate-drain)		Qg		_	20	_	
Gate-source charge 1		Q _{gs1}	$V_{DD} \simeq 16 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 6 \text{ A}$		3.5		nC
Gate-drain ("miller") charge		Q _{gd}		_	4.5	_	

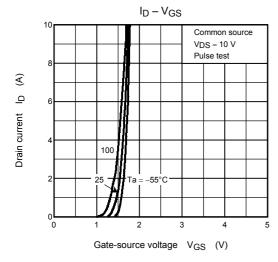
Source-Drain Ratings and Characteristics (Ta = 25°C)

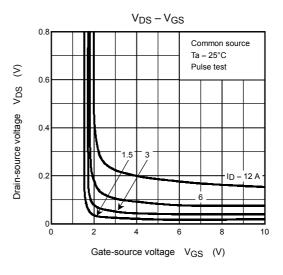
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	24	Α
Forward voltage (diode)		V_{DSF}	I _{DR} = 6 A, V _{GS} = 0 V	_	_	-1.2	V

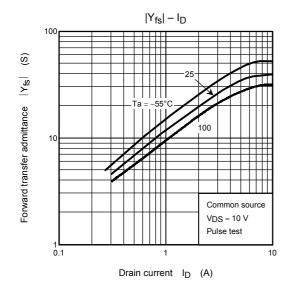
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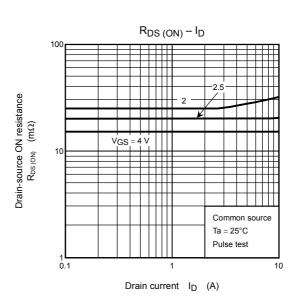




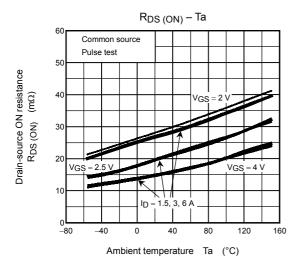


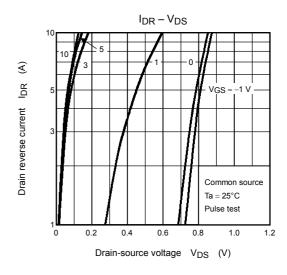


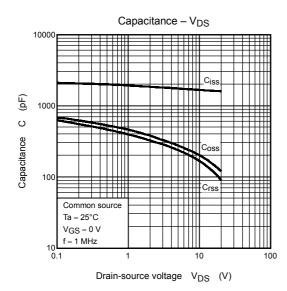


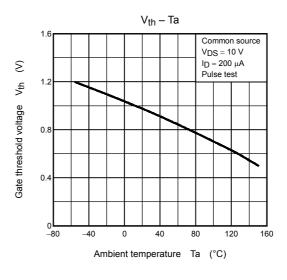


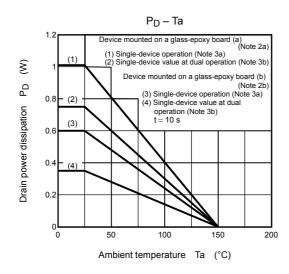
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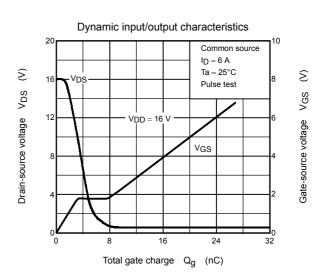


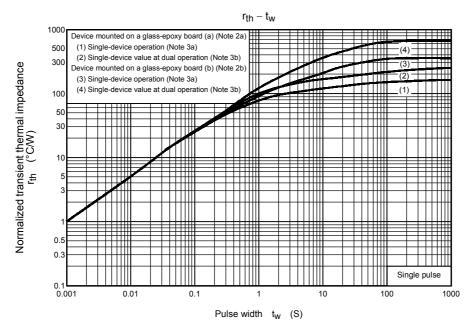




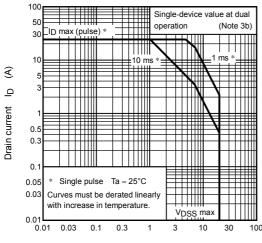












Drain-source voltage V_{DS} (V)

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